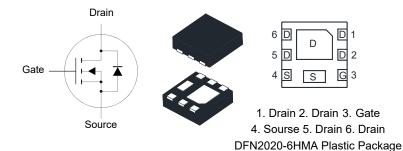
### N-Channel Enhancement Mode Power MOSFET

#### **Features**

- AEC-Q101 Qualified
- Ideal for Low Profile Applications
- Low On-Resistance
- Low Gate Threshold Voltage
- Halogen and Antimony Free(HAF), RoHS compliant



#### **Applications**

- Battery Management Application
- Power Management Functions
- DC-DC Converters

#### Absolute Maximum Ratings (at Ta = 25°C unless otherwise specified)

<u> </u>	-	•		
Parameter	Symbol	Value	Unit	
Drain-Source Voltage		V <sub>DS</sub>	30	V
Gate-Source Voltage		V <sub>GS</sub>	± 20	V
Drain Current at V <sub>GS</sub> = 10 V, Steady State	T <sub>a</sub> = 25°C T <sub>a</sub> = 70°C	ID	10 8	Α
Drain Current at V <sub>GS</sub> = 10 V, t < 10 s	T <sub>a</sub> = 25°C T <sub>a</sub> = 70°C	ID	12 9	Α
Pulsed Drain Current 1)		I <sub>DM</sub>	50	Α
Avalanche Current		las	20	А
Single Pulse Avalanche Energy 4)		E <sub>AS</sub>	20	mJ
Total Power Dissipation 2)	T <sub>a</sub> = 25°C T <sub>a</sub> = 70°C	P <sub>tot</sub>	1.4 0.85	W
Operating Junction and Storage Temperatur	$T_{j}$ , $T_{stg}$	- 55 to + 150	°C	

### **Thermal Characteristics**

Parameter		Symbol	Max.	Unit
Thermal Resistance from Junction to Ambient <sup>2)</sup>	Steady State t < 10 s	R <sub>θ</sub> ЈА	90 75	°C/W
Thermal Resistance from Junction to Ambient 3)	Steady State t < 10 s	R <sub>θ</sub> ЈА	125 100	°C/W

<sup>&</sup>lt;sup>1)</sup> Pulse Test: Pulse Width ≤ 100 μs, Duty Cycle ≤ 2%, Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub> = 150°C.



<sup>&</sup>lt;sup>2)</sup> Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

<sup>&</sup>lt;sup>3)</sup> Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

<sup>&</sup>lt;sup>4)</sup> Limited by  $T_{J(max)}$ , starting  $T_J = 25$  °C, L = 0.1 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 20A$ ,  $V_{GS} = 10 V$ .

## Characteristics at Ta = 25°C unless otherwise specified

Parameter	Symbol	Min.	Тур.	Max.	Unit
STATIC PARAMETERS					
Drain-Source Breakdown Voltage at I <sub>D</sub> = 250 μA	BV <sub>DSS</sub>	30	-	-	V
Drain-Source Leakage Current at $V_{DS}$ = 30 V	I <sub>DSS</sub>	-	-	1	μΑ
Gate Leakage Current at V <sub>GS</sub> = ± 20 V	Igss	-	-	± 100	nA
Gate-Source Threshold Voltage at $V_{DS}$ = $V_{GS}$ , $I_D$ = 250 $\mu$ A	V <sub>GS(th)</sub>	1	-	2	V
Drain-Source On-State Resistance at $V_{GS}$ = 10 V, $I_D$ = 11 A at $V_{GS}$ = 4.5 V, $I_D$ = 9 A	R <sub>DS(on)</sub>	- -	- -	12 16	mΩ
DYNAMIC PARAMETERS					
Gate resistance at $V_{DS} = 0 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$	Rg	-	1.8	-	Ω
Input Capacitance at $V_{DS}$ = 15 V, $V_{GS}$ = 0 V, f = 1 MHz	C <sub>iss</sub>	-	1128	-	pF
Output Capacitance at $V_{DS}$ = 15 V, $V_{GS}$ = 0 V, f = 1 MHz	Coss	-	151	-	pF
Reverse Transfer Capacitance at $V_{DS}$ = 15 V, $V_{GS}$ = 0 V, f = 1 MHz	Crss	-	106	-	pF
Total Gate Charge at $V_{DS}$ = 15 V, $I_D$ = 10 A, $V_{GS}$ = 10 V at $V_{DS}$ = 15 V, $I_D$ = 10 A, $V_{GS}$ = 4.5 V	$Q_g$	-	25 11	-	nC
Gate to Source Charge at $V_{DS}$ = 15 V, $I_D$ = 10 A, $V_{GS}$ = 10 V	$Q_{gs}$	-	5.1	-	nC
Gate to Drain Charge at $V_{DS}$ = 15 V, $I_D$ = 10 A, $V_{GS}$ = 10 V	$Q_{gd}$	-	6.5	-	nC
Turn-On Delay Time at $V_{DD}$ = 15 V, $V_{GS}$ = 10 V, $I_D$ = 10 A, $R_G$ = 4.7 $\Omega$	t <sub>d(on)</sub>	-	15.8	-	ns
Turn-On Rise Time at $V_{DD}$ = 15 V, $V_{GS}$ = 10 V, $I_D$ = 10 A, $R_G$ = 4.7 $\Omega$	t <sub>r</sub>	-	72.5	-	ns
Turn-Off Delay Time at $V_{DD}$ = 15 V, $V_{GS}$ = 10 V, $I_D$ = 10 A, $R_G$ = 4.7 $\Omega$	$t_{d(off)}$	-	15.5	-	ns
Turn-Off Fall Time at $V_{DD}$ = 15 V, $V_{GS}$ = 10 V, $I_D$ = 10 A, $R_G$ = 4.7 $\Omega$	t <sub>f</sub>	-	22	-	ns
Body-Diode PARAMETERS					
Drain-Source Diode Forward Voltage at I <sub>S</sub> = 1 A, V <sub>GS</sub> = 0 V	V <sub>SD</sub>	-	0.8	1.2	V
Body-Diode Continuous Current	Is	-	-	10	Α
Body Diode Reverse Recovery Time at I <sub>S</sub> = 10 A, di/dt = 100 A / μs	t <sub>rr</sub>	-	11	-	ns
Body Diode Reverse Recovery Charge at I <sub>S</sub> = 10 A, di/dt = 100 A / µs	Q <sub>rr</sub>	-	3.2	-	nc



#### **Electrical Characteristics Curves**

Fig. 1 Typical Output Characteristics

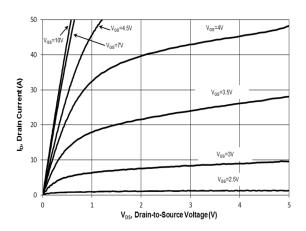


Fig. 3 R<sub>DS(on)</sub> vs. Gate-Source Voltage

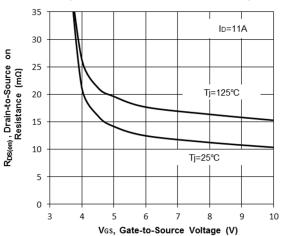


Fig. 5 on-Resistance vs. Drain Current

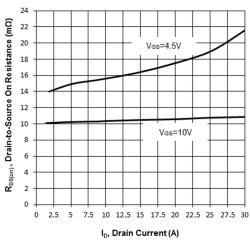


Fig. 2 Typical Transfer Characteristics

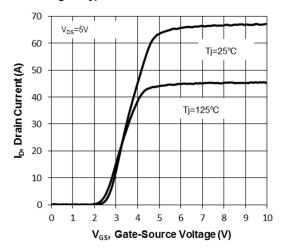


Fig. 4 on-Resistance vs.T<sub>j</sub>

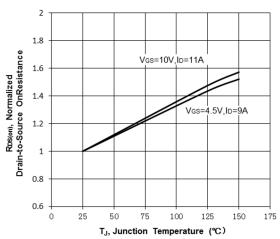
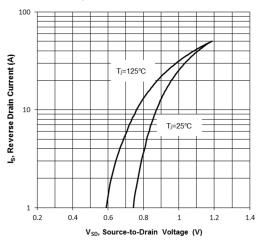


Fig. 6 Forward Characteristics





#### **Electrical Characteristics Curves**

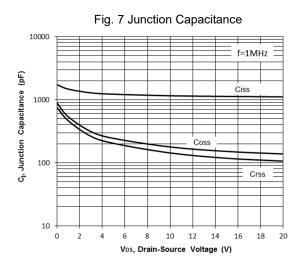


Fig. 9 Gate Threshold Variation vs. Tj

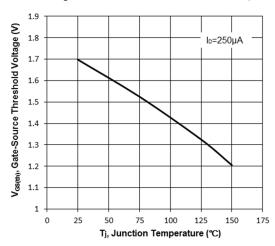


Fig.11 B<sub>VDSS</sub> vs. Temperature

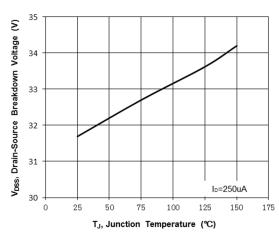


Fig. 8 Gate Charge

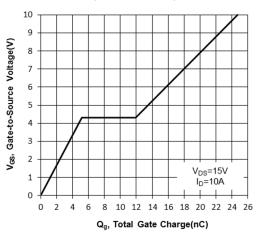


Fig. 10 Drain Leakage Current vs. Tj

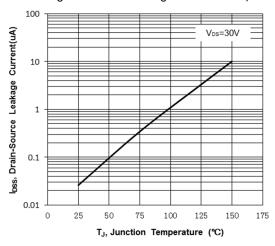
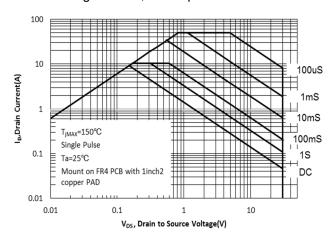


Fig.12 SOA, safe Operation Area





#### **Electrical Characteristics Curves**

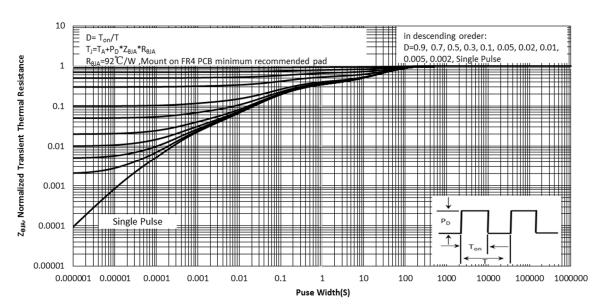
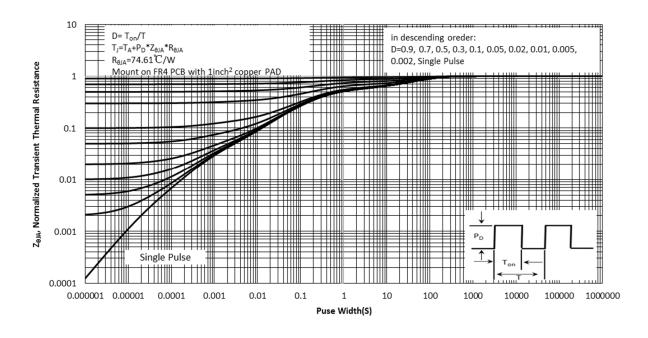


Fig.13 Transient Thermal Resistance

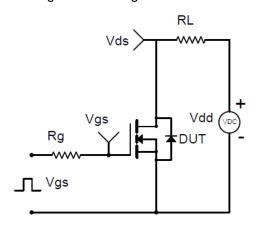






## **Test Circuits**

Fig.1-1 Switching times test circuit



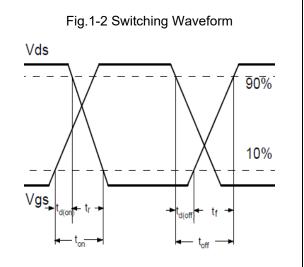


Fig.2-1 Gate charge test circuit

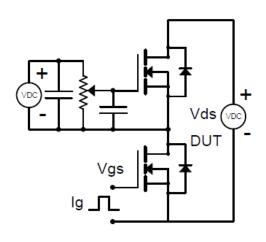


Fig.2-2 Gate charge waveform

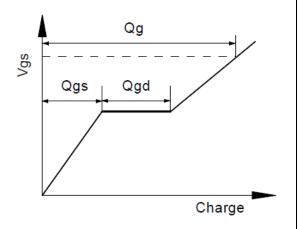


Fig.3-1 Avalanche test circuit

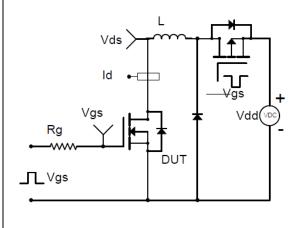
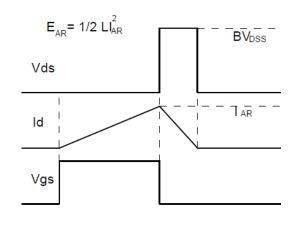


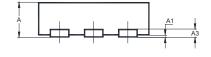
Fig.3-2 Avalanche waveform

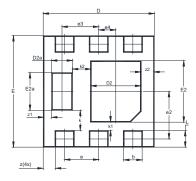




#### Package Outline Dimensions (Units: mm)

#### DFN2020-6HMA





UNIT	Α	A1	A3	b	D	D2	D2a	E	E2	E2a	L
mm	0.55	0	0.15	0.25	1.95	0.85	0.33	1.95	1.05	0.65	0.225
mm	0.65	0.05	Тур.	0.35	2.05	1.05	0.43	2.05	1.25	0.75	0.325

UNIT	е	e2	e3	e4	k	k1	k2	Z	z1	z2
mm	0.65	0.863	0.7	0.325	0.37	0.15	0.36	0.2	0.11	0.2
	BSC	BSC	BSC	BSC	BSC	BSC	BSC	BSC	BSC	BSC

### **Recommended Soldering Footprint**



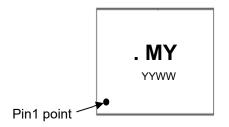
### **Packing information**

5 .	Tape Width	ı	itch Reel		Size		
Package	(mm)	mm	inch	mm	inch	Per Reel Packing Quantity	
DFN2020-6HMA	8	4 ± 0.1	0.157 ± 0.004	178	7	4,000	

## **Marking information**

- " MY " = Part No.
- " " = HAF (Halogen and Antimony Free)
- " YYWW " = Date Code Marking
- " Y " = Year (ex: 19 = 2019)
- "W" = Week (ex: 09 = the 9th week of the year)

Font type: Arial



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